Search Notes				

Application/Control No.	Applicant(s)/Patent under Reexamination
10/784,304	UCHIDA
Examiner	Art Unit
Noil Abromo	2830

	SEAR	CHED	
Class	Subclass	Date	Examiner
439	140	4-5-03	na
	141		

INI	INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner		
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SEARCH (INCLUDING SEA	I NOTES RCH STRATEG	Y)
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